



SW Test Workshop
Semiconductor Wafer Test Workshop

Design and Analysis of Space Transformer with Hybrid Circuit Design on Probe Card

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June 3-6, 2018

Overview

- *Introduction of Probe Card Test*
- *Design Concept of Space Transformer*
- *Signal Integrity and Power Integrity*
- *Measurement and Analysis*
- *Summary*

Introduction of Probe Card Test

• Trend of Wafer Memory Test

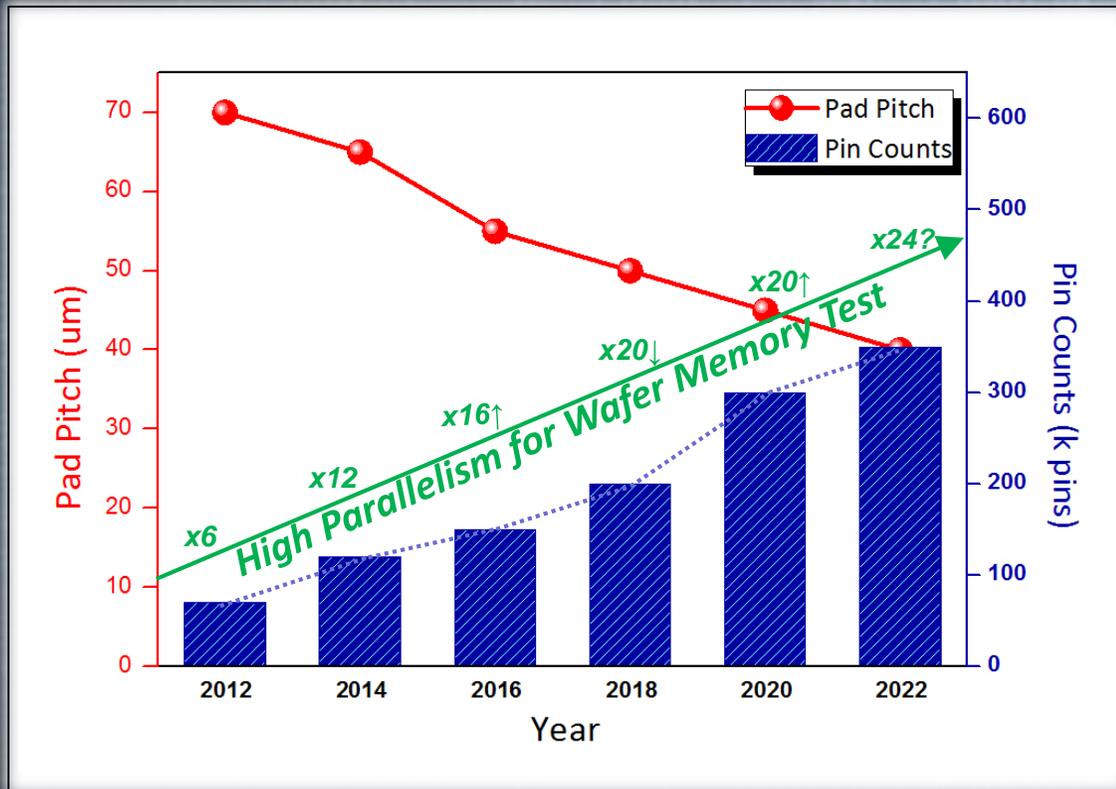
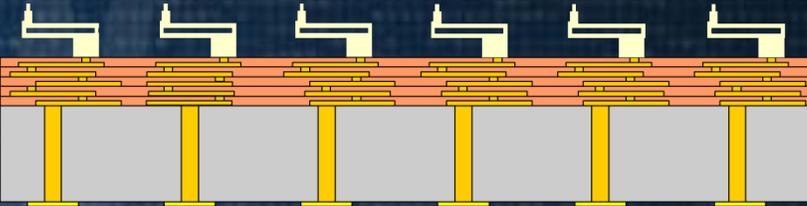
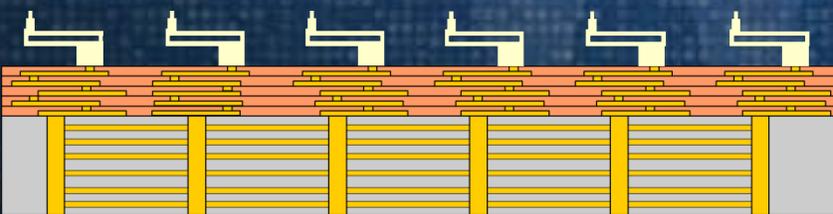
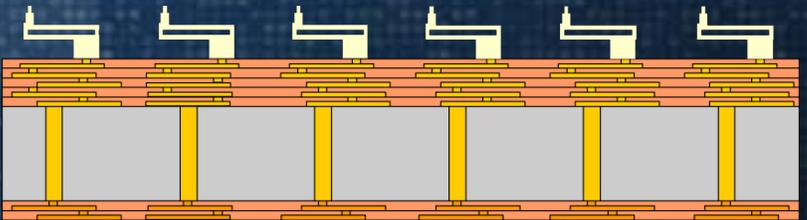


Fig. Trend of Pad Pitch and Pin Counts (High Parallelism) for Wafer Test

- ✓ Shrinking Pad Size and Reducing Pad Pitch
 - ✓ Increasing Pin Counts for High Parallelism Test
 - ✓ Fasting Clock Speed and Small Timing Margin
 - ✓ High Density Circuit Design for Fine Pitch
 - ✓ Signal & Power Issues and Design Considerations
-
- Needs for High Performance and Technique of Space Transformer

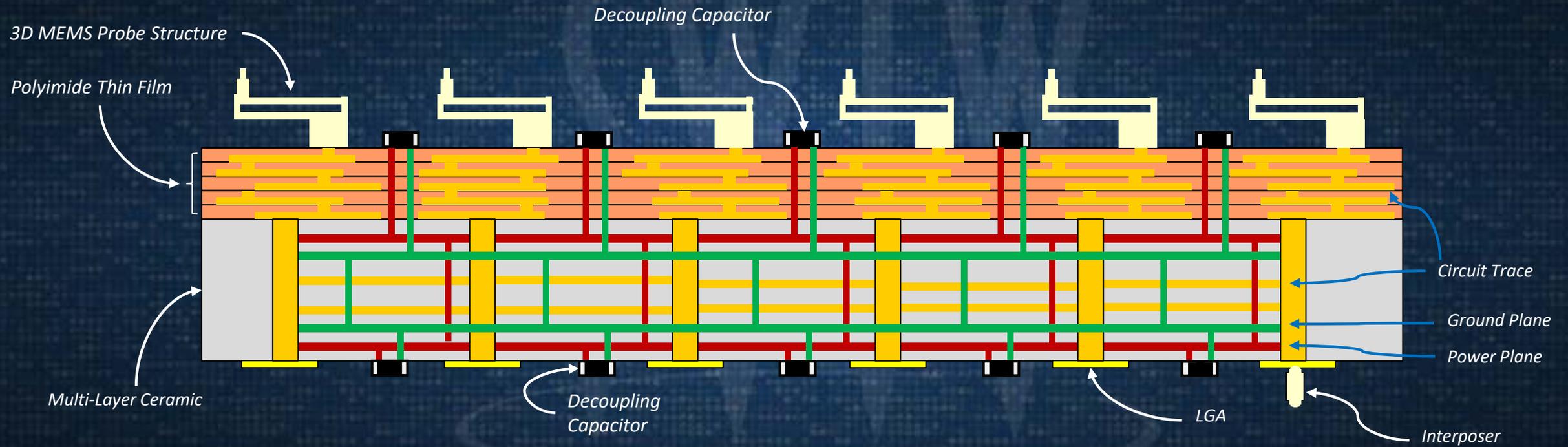
Design Concept of Space Transformer

- Concept of Space Transformer for Circuit Design

<p>Normal Type</p>		<p>Polyimide Type (One Side)</p>	
	<p>Fine Pitch ★ ★ ★ Circuit Density ★ ★ Technology ★ ★ ★</p>		<p>Fine Pitch ★ ★ ★ ★ ★ Circuit Density ★ ★ ★ ★ Technology ★ ★ ★ ★</p>
<p>Hybrid Type</p>		<p>Polyimide Type (Two Side)</p>	
	<p>Fine Pitch ★ ★ ★ ★ ★ Circuit Density ★ ★ ★ Technology ★ ★ ★ ★</p>		<p>Fine Pitch ★ ★ ★ ★ ★ Circuit Density ★ ★ ★ ★ ★ Technology ★ ★ ★ ★ ★</p>

Design Concept of Space Transformer

- Hybrid Type (Circuit on Polyimide + Multi-Layer Ceramic) Space Transformer



- Hybrid Space Transformer composed of Polyimide Thin Film and Multi-Layer Ceramic
- Signal Integrity, Power Integrity Characteristics (Signal Trace, Power & Ground Plane, Impedance Matching)

Signal Integrity of Space Transformer

• Design Considerations and Basic Study

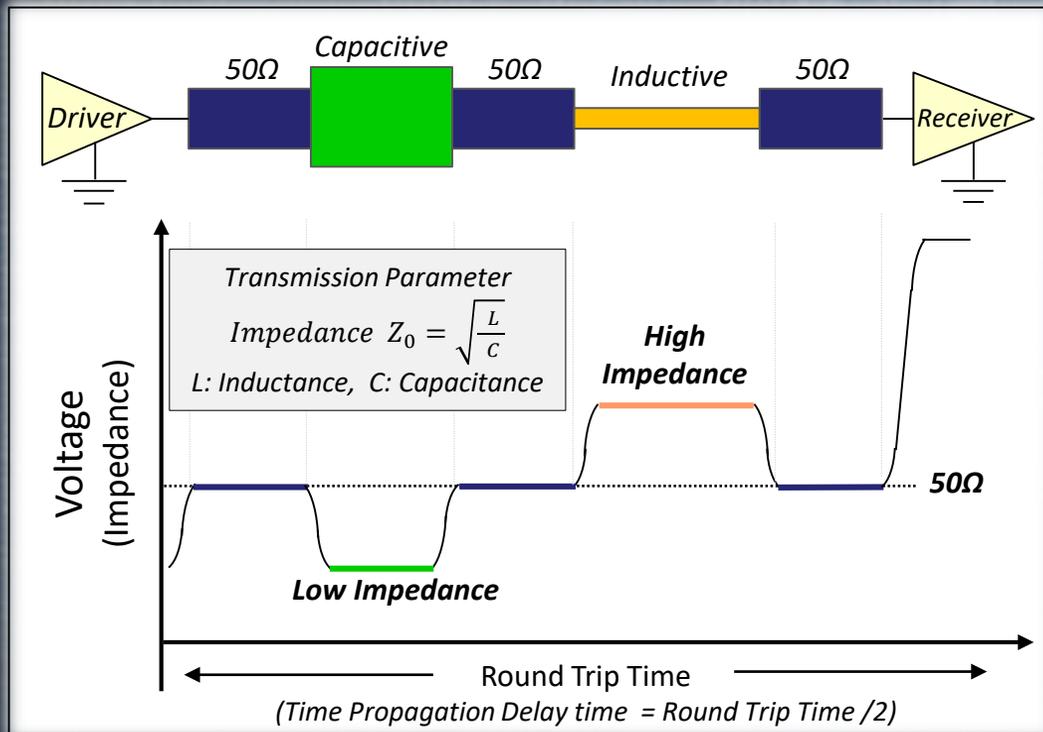


Fig. Time Domain Reflectometry (TDR) of Transmission Line

- ✓ Impedance Mismatch
 - Transmission Line Signal Loss and Distortion
 - Reflection and Bad Signal Quality
- ✓ Unintentional Discontinuity
 - Stub, Test Pad, Neck of Via, Trace Corner, Trace Branch, Connectors, Crossover, etc.



Fig. Signal Stack Via

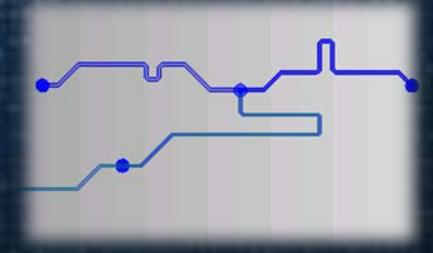


Fig. Signal Trace Branch

Signal Integrity of Space Transformer

• Design Considerations and Basic Study

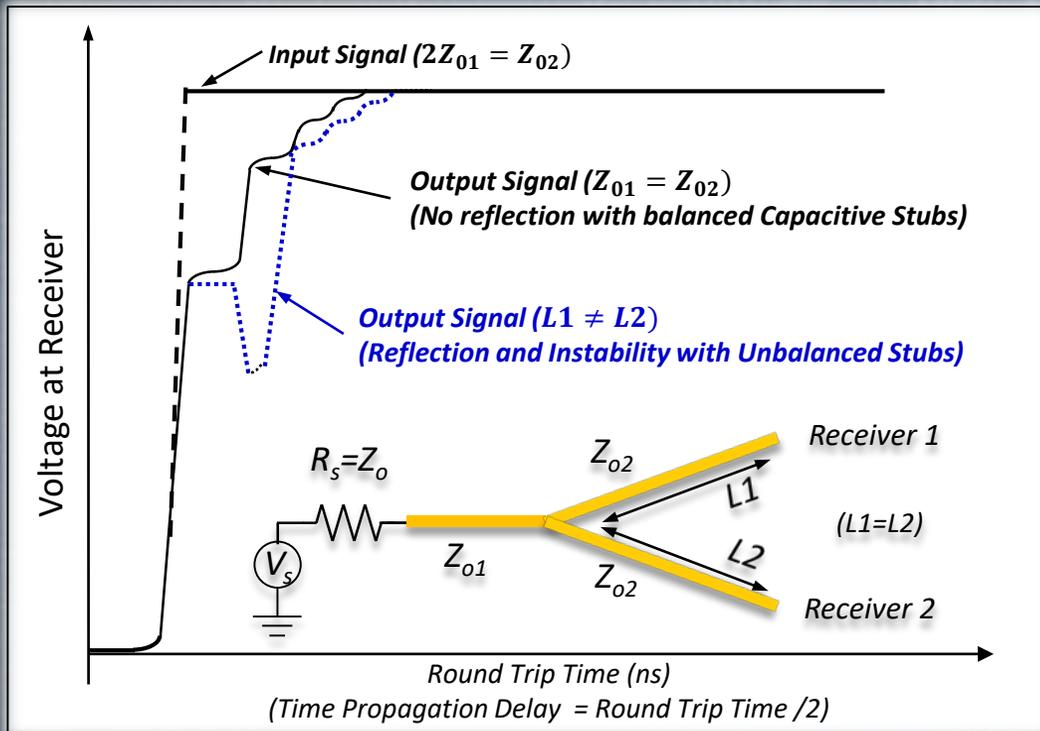


Fig. Signal Integrity produced by Stubs

- ✓ One Driver is Connected to Multi-Receiver
 - Impedance $2Z_{01} = Z_{02}$: No Reflection
 - Impedance $Z_{01} = Z_{02}$: Step Reflection
 - Unbalanced Structure ($L1 \neq L2$) : Instability
- ✓ Best Topology for Stub Design
 - Symmetric Topology (Length)
 - Minimize Impedance Discontinuity
- Challenge for Designing Multi-Stubs Trace on Space Transformer

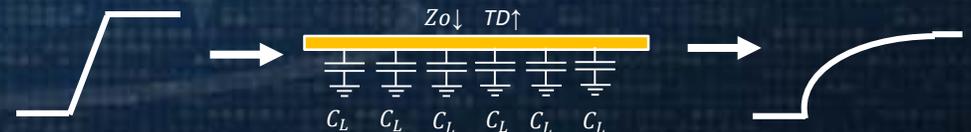


Fig. Effect of Distributed Short Capacitive Stubs

Signal Integrity of Space Transformer

- Design Considerations and Basic Study (Pre-Simulation and Case-Study)

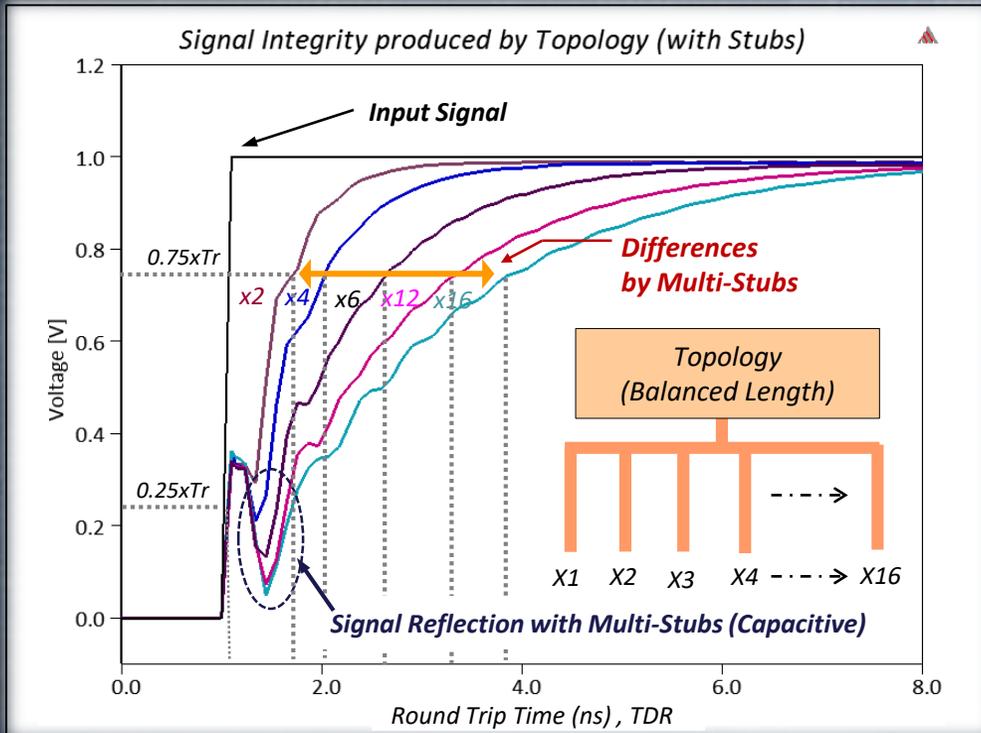


Fig. Propagation Delay Time (TPD) with Multi-Stubs Topology

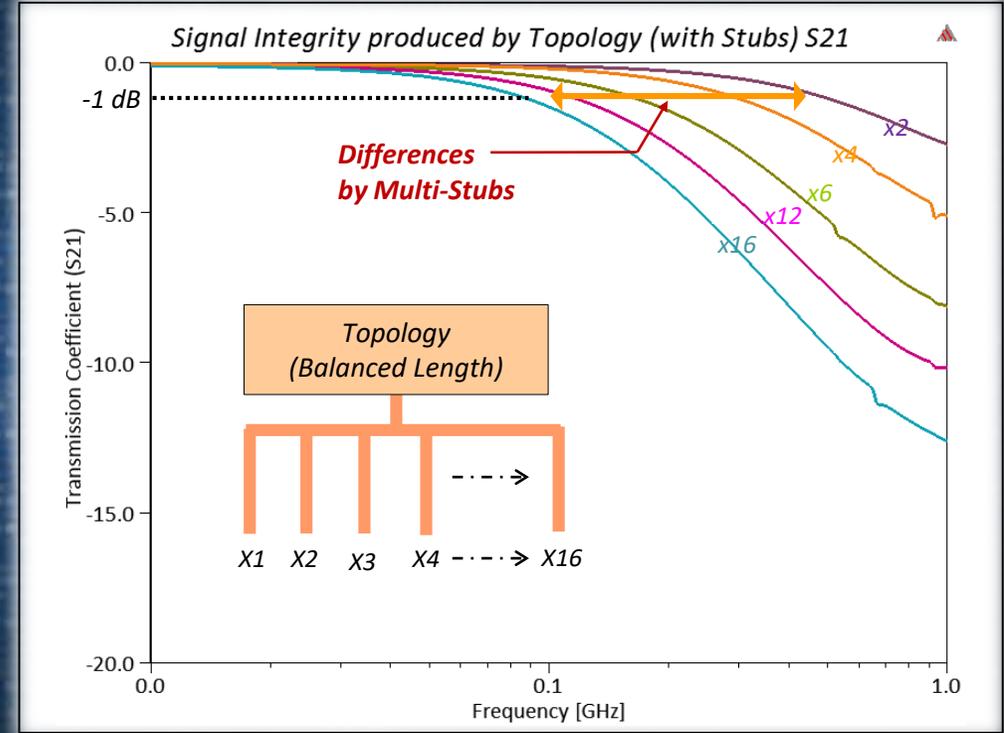


Fig. Transmission Coefficient (Insertion Loss)

- ✓ Signal Integrity produced by Multi-Stubs Topology (Increasing Capacitive and Impedance Mismatching)

Power Integrity of Space Transformer

- *Design Considerations and Basic Study*

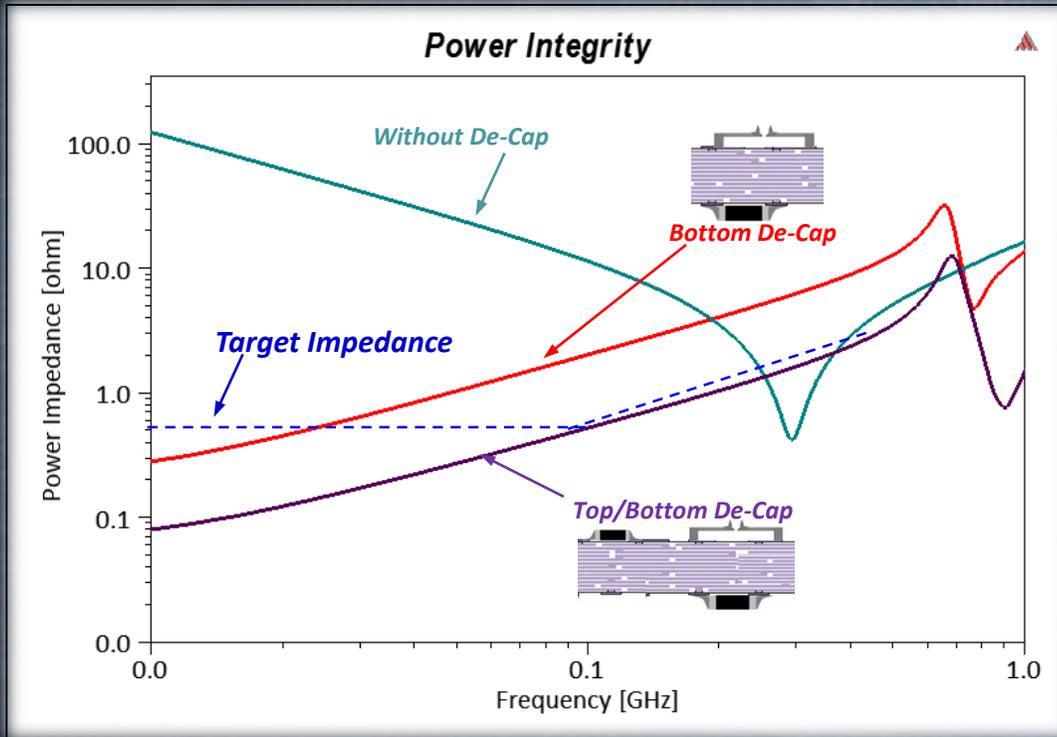


Fig. Power Integrity with Decoupling Capacitor

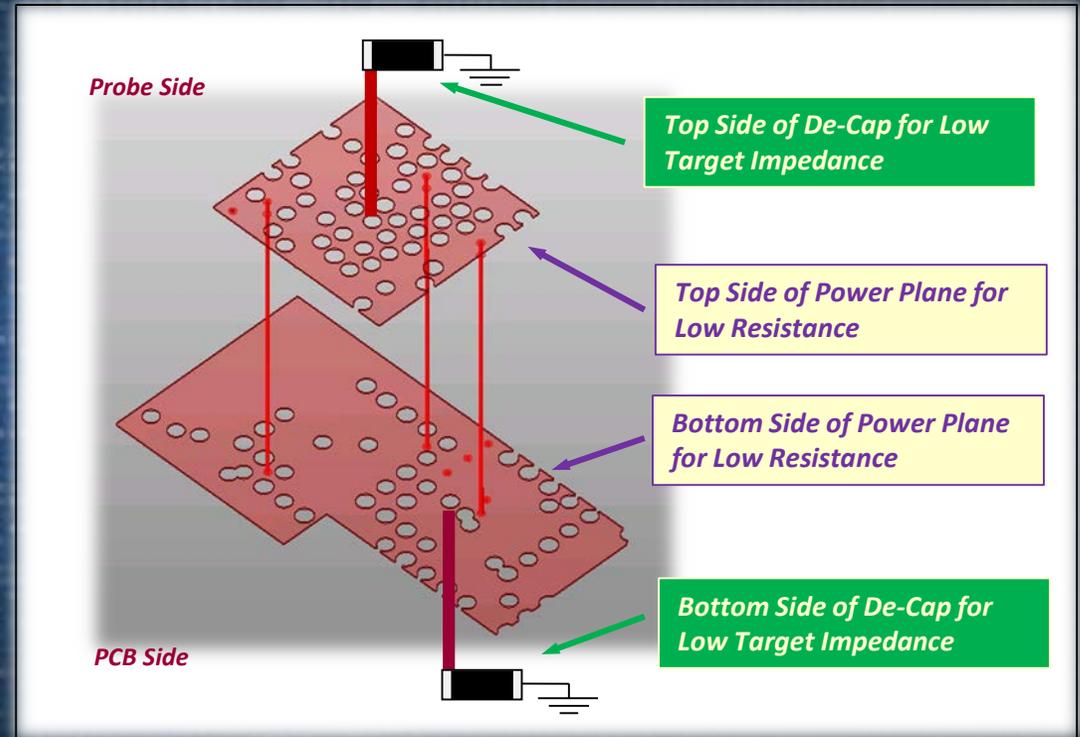


Fig. Power Plane Design for Low Resistance

✓ *Power (Target) Impedance can be Controlled by using Decoupling Capacitor and Position*

Signal Integrity of Space Transformer

- Design Signal Trace on Space Transformer (Hybrid Type and Normal Type)

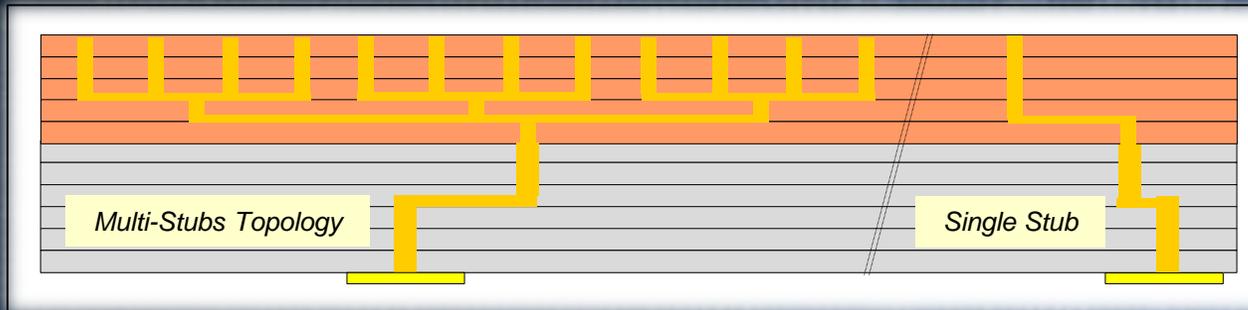


Fig. Simplified Signal Design of Hybrid Space Transformer

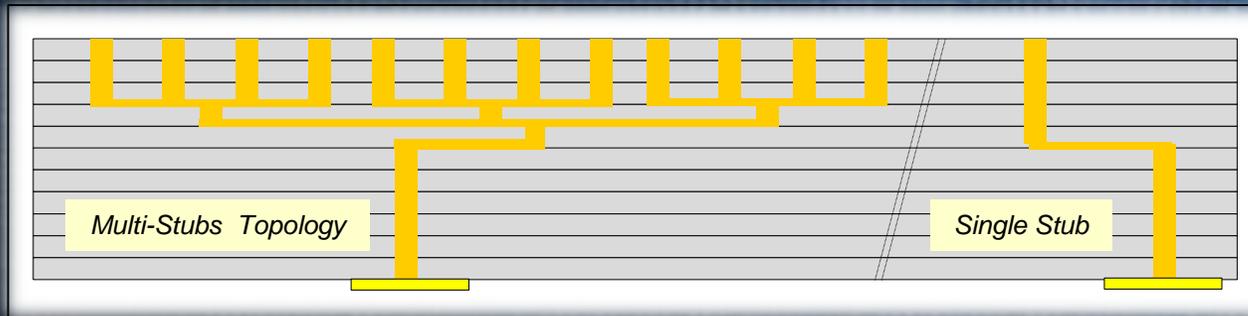


Fig. Simplified Signal Design of Normal Space Transformer

- ✓ Signal Design Considerations
 - Single Stub Design (Simple Trace Line)
 - Multi-Stubs Design Topology ($\geq x12$)
 - Balanced Topology for Multi-Parallelism Test
- ✓ Design Factors
 - Balanced Stub Topology, Length, Impedance
- ✓ Signal Integrity
 - TPD, Skew, Transmission Coefficient, Eye Diagram

Power Integrity of Space Transformer

- Design Power Plane on Space Transformer (Hybrid Type and Normal Type)

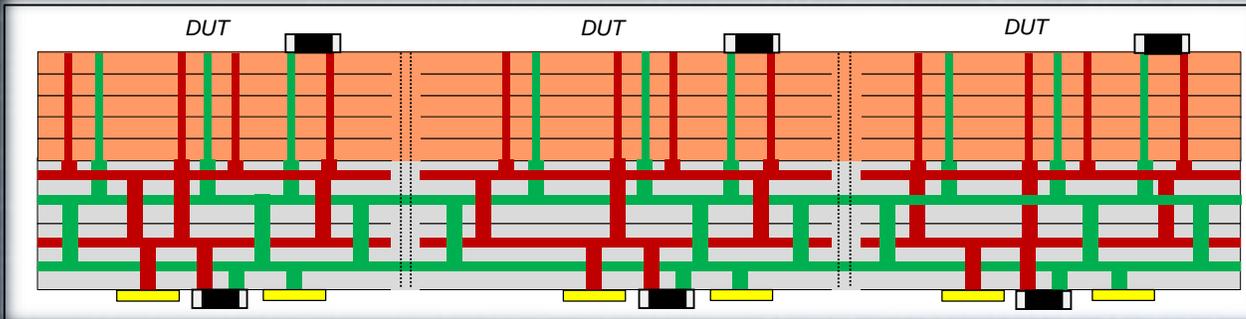


Fig. Simplified Power Design of Hybrid Space Transformer

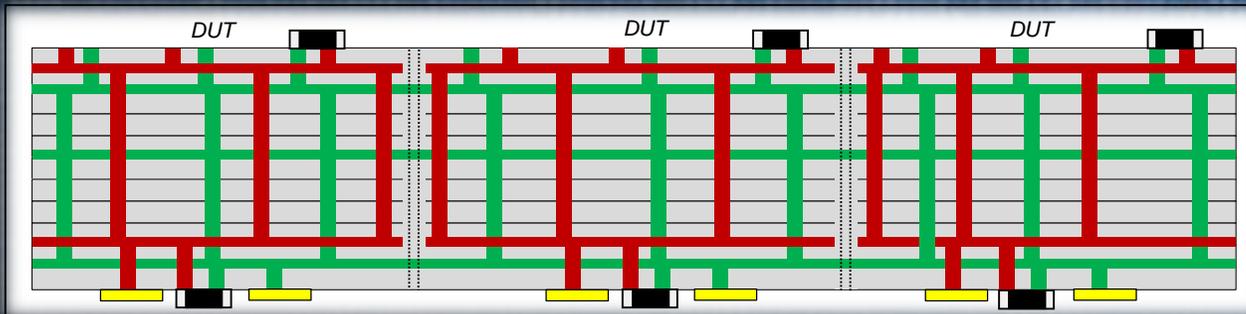


Fig. Simplified Power Design of Normal Space Transformer

- ✓ Power Design Considerations
 - Low Power Resistance
 - Power Impedance (Target Impedance)
 - Ground Plane (Return Current Path)
- ✓ Design Factors
 - Power and Ground Plane, De-cap Capacity, Position of Decoupling Capacitor
- ✓ Power Integrity
 - Power Impedance, Target impedance, SSN (Simultaneous Switching Noise)

Signal Integrity of Space Transformer

• Measured Insertion Loss and Comparison of Two Types of Space Transformer

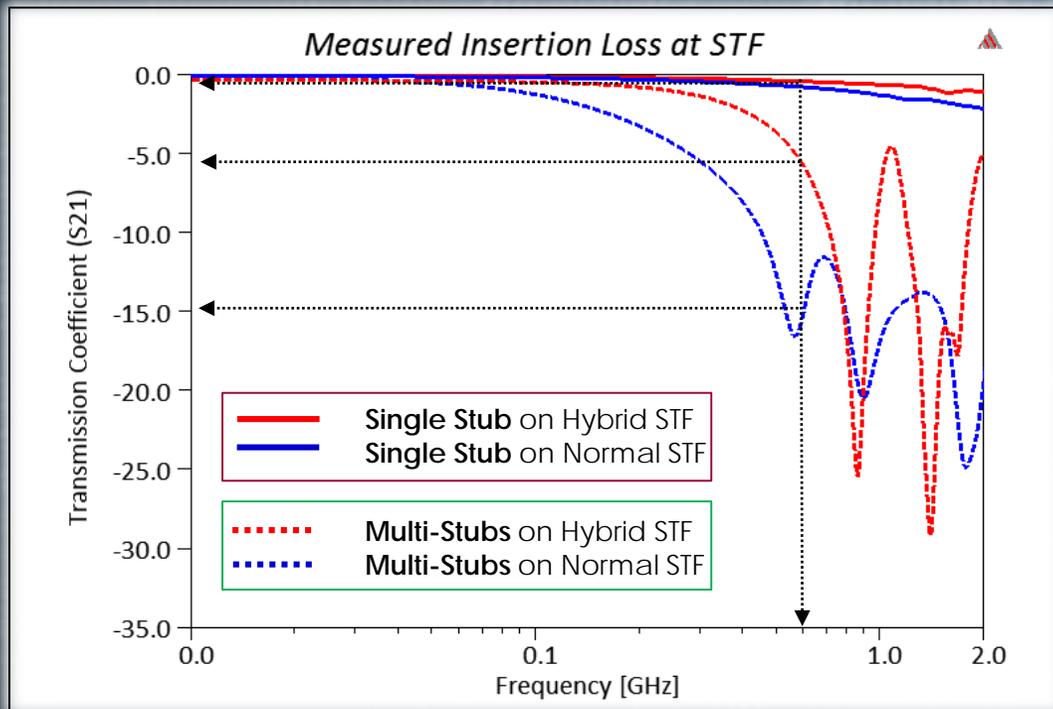


Fig. Insertion Loss of Two Different Types of STF

- ✓ *Single Stub Topology*
 - Measured Single Stub Trace
 - Compared of Hybrid and Normal Type
 - Slightly Differences of Insertion Loss
- ✓ *Multi-Stubs Topology*
 - Measured Multi-Stubs Trace (x12)
 - Compared of Hybrid and Normal Type
 - Multi-Stubs Trace (x12) Balanced Length Design
 - Large Differences of Insertion Loss
- *For Multi-Stubs Topology, Hybrid Space Transformer Design is much more Effective*

Signal Integrity of Space Transformer

• Measured TDR and Comparison of Two Types of Space Transformer

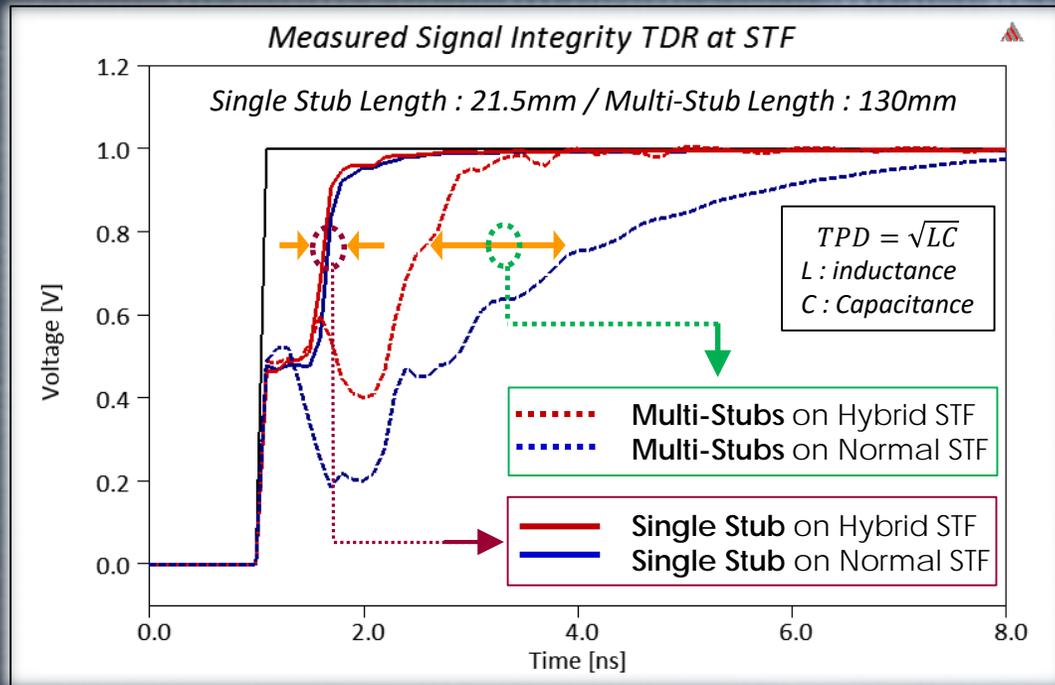


Fig. Propagation Delay Time (TPD) of Two Types of STF

- ✓ Measured TDR (Time Domain Reflectometry)
 - Analyze for Impedance Mismatching Point
 - Propagation Velocity, TPD (Propagation Delay Time)

$$TPD = \frac{\lambda \times \sqrt{\epsilon_r}}{c}$$

λ : Length, ϵ_r : Dielectric Constant
 c : Speed of light (3×10^8 m/s)

- ✓ Polyimide ϵ_r 3.4, Multilayer Ceramic ϵ_r 8 ~ 10
 - ex) Propagation Velocity of Polyimide, 1 mm = 6.15 ps/mm
 - Propagation Velocity of Ceramic, 1 mm = 10.5 ps/mm
- ✓ The Propagation Velocity of Transmission Line on Polyimide **1.7 times** faster than Ceramic
 - If Multi-Stubs Length is much longer, the TPD of Polyimide Circuit is much faster than Ceramic Design

Signal Integrity of Space Transformer

- Measurement of Propagation Delay Time on Probe Card (Including Hybrid STF)

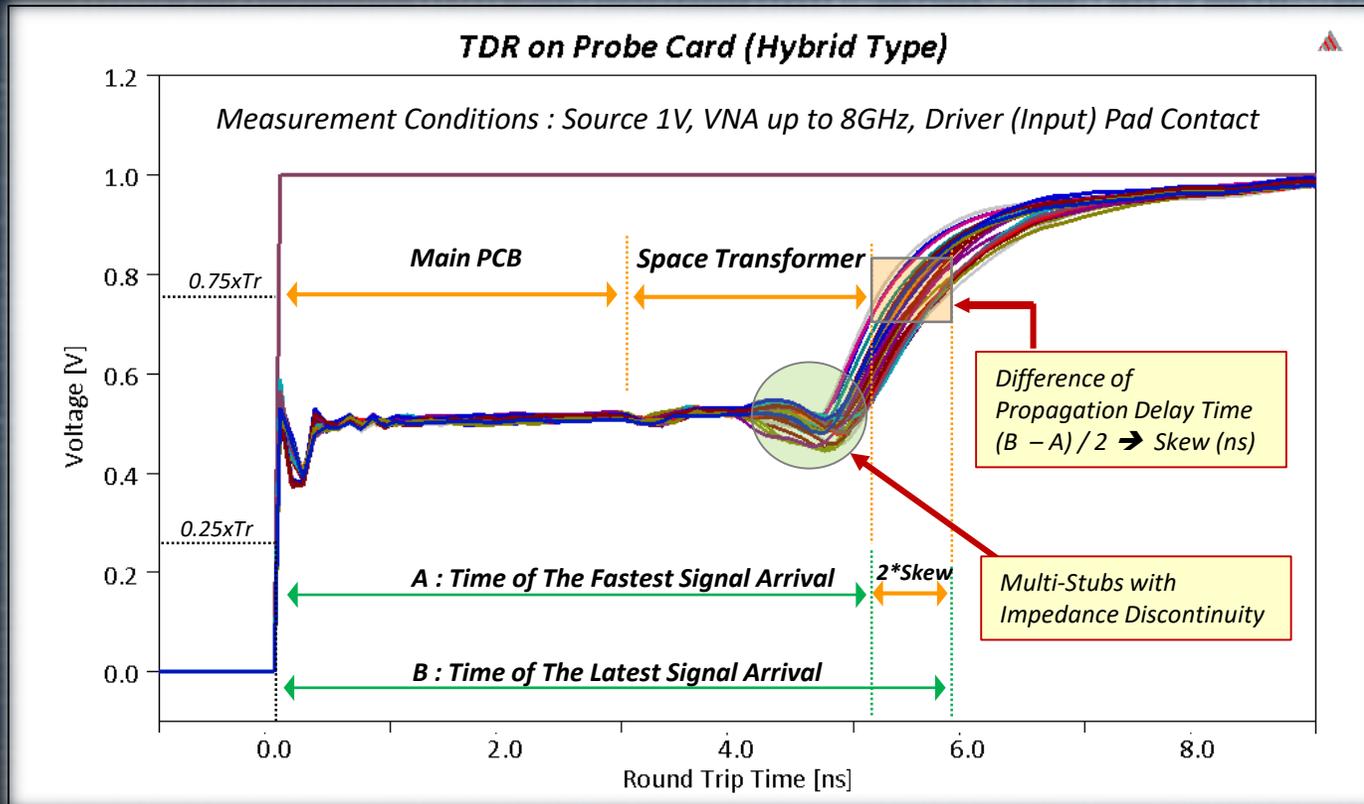
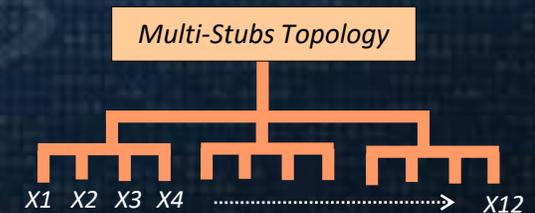


Fig. Measured TDR on Probe Card (Hybrid Space Transformer Type)

- ✓ Measured of TDR on Probe Card
 - TPD= Round Trip time / 2
 - Skew (Time Differences by Topology)
 - (The Latest Signal - The Fastest Signal) / 2
- ✓ Analyzed TDR of Probe Card
 - Multi-Stubs Topology makes Signal Reflection and Impedance Discontinuities at the Stubs Junctions



Power Integrity of Space Transformer

• Measured Power Impedance (Comparison of Two Types of Space Transformer)

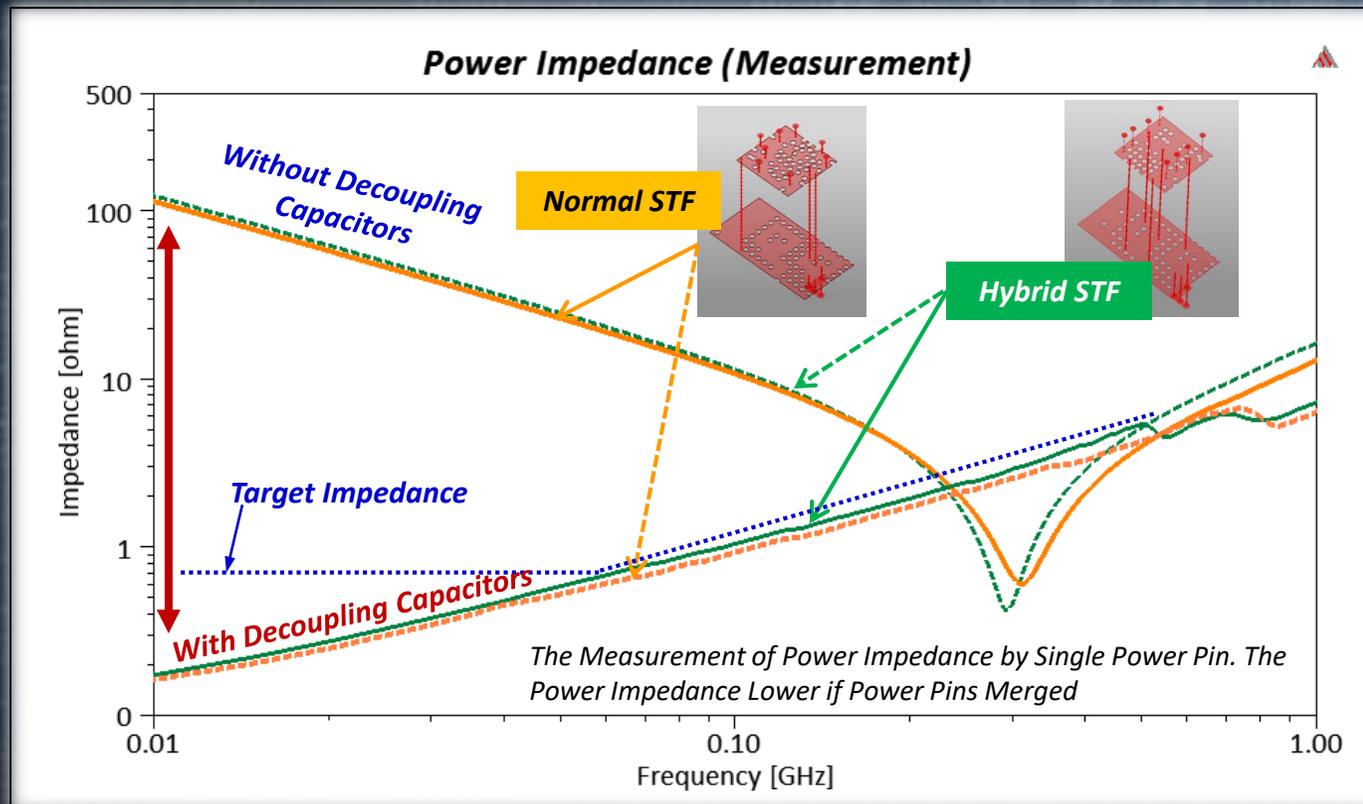


Fig. Measurement of Power Integrity

- ✓ Power Integrity Comparison
 - Normal Type and Hybrid Type
 - Measurement for Single Power Pin
 - Target impedance,
- ✓ Without Decoupling Capacitors
 - Capacitance and Inductance of Plane
 - Characteristics (Impedance, Resonance)
- ✓ With Decoupling Capacitors
 - Decoupling Capacitors affect Power Impedance and lower Noise Level

Power Integrity of Space Transformer

- SSN (Power Noise with Decoupling Capacitor Effect) at Normal Space Transformer

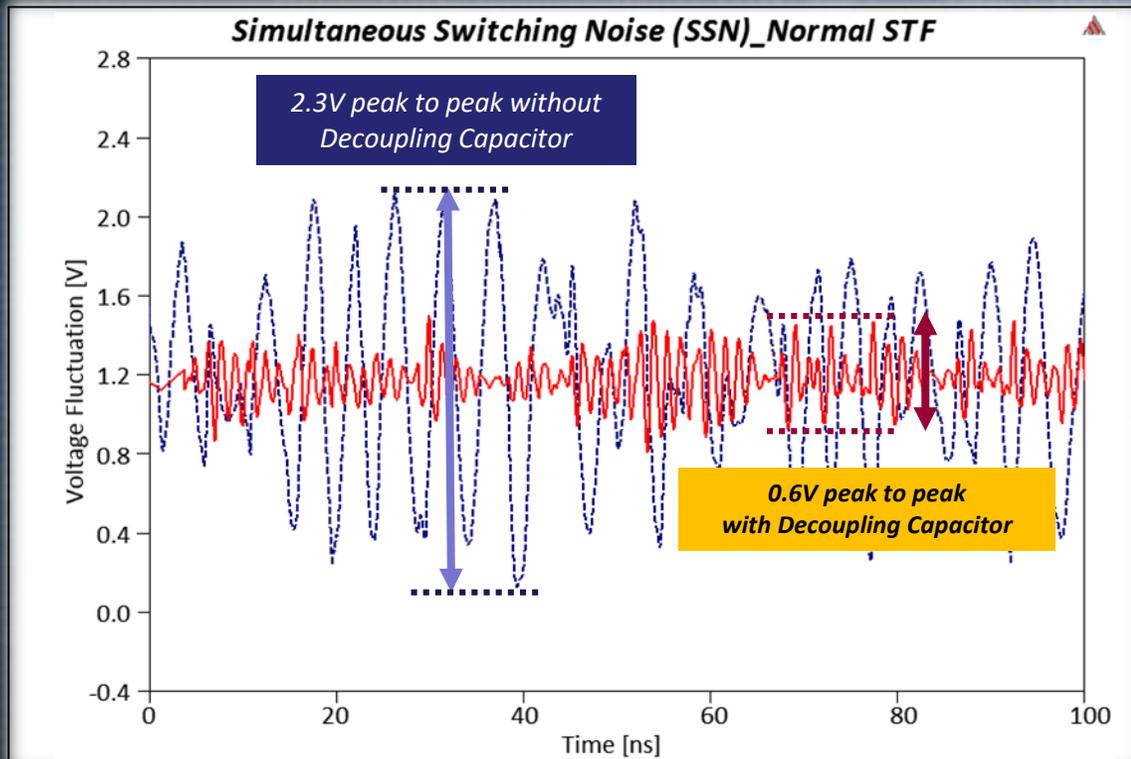


Fig. SSN at Normal Space Transformer

- ✓ SSN Analysis for Normal STF
 - De-Capacitor reducing Power Noise
 - Effect for Both Side of Decoupling Local
- ✓ Power Plane Design reducing Inductance
 - Maximum the Number of Power Pins
 - Placing De-cap as close as possible to Device Side

- Simultaneous Switching Noise (SSN)

$$\Delta V = NL \frac{\Delta I}{\Delta t}$$

N : Number of Switching Driver
 ΔI : Increase of Maximum Power (Current)
 Δt : Increase of Clock Frequency

- SSN caused by Simultaneous Switching Output Buffers

Power Integrity of Space Transformer

- SSN (Power Noise with Decoupling Capacitor Effect) at Hybrid Space Transformer

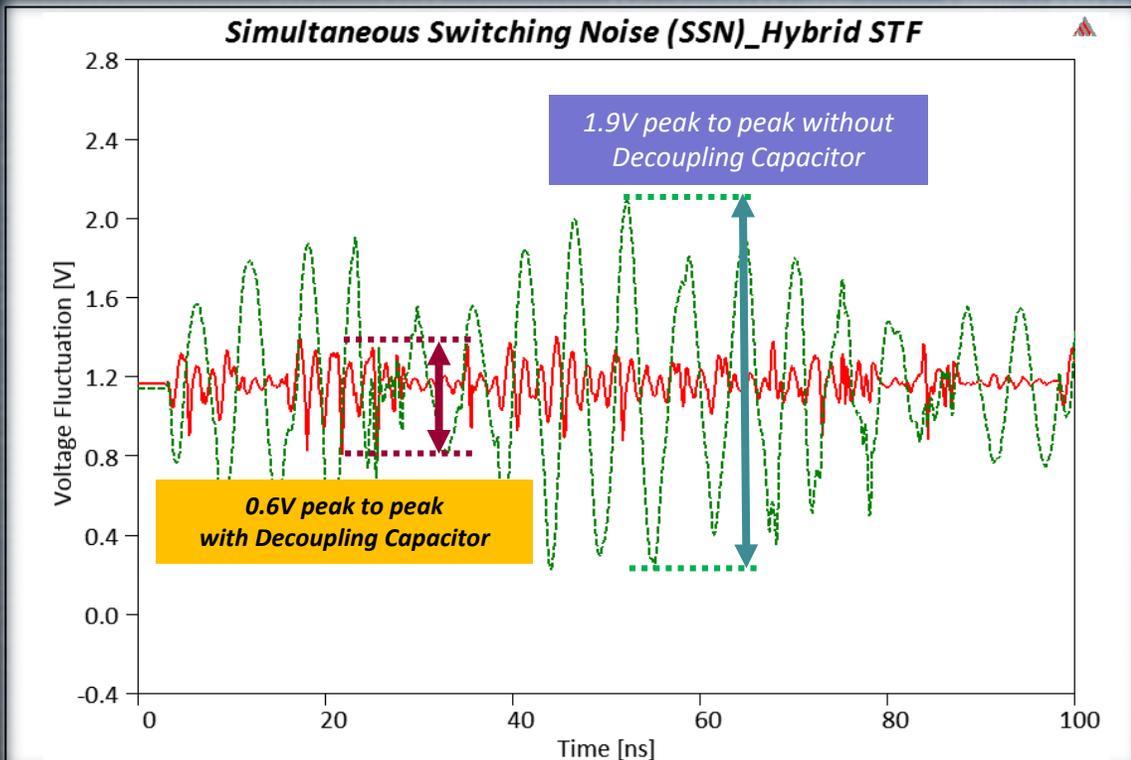


Fig. SSN at Hybrid Space Transformer

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Signal Integrity of Space Transformer

- Measurement of Eye Diagram (Comparison of Two Types of Space Transformer)

Normal Type Space Transformer

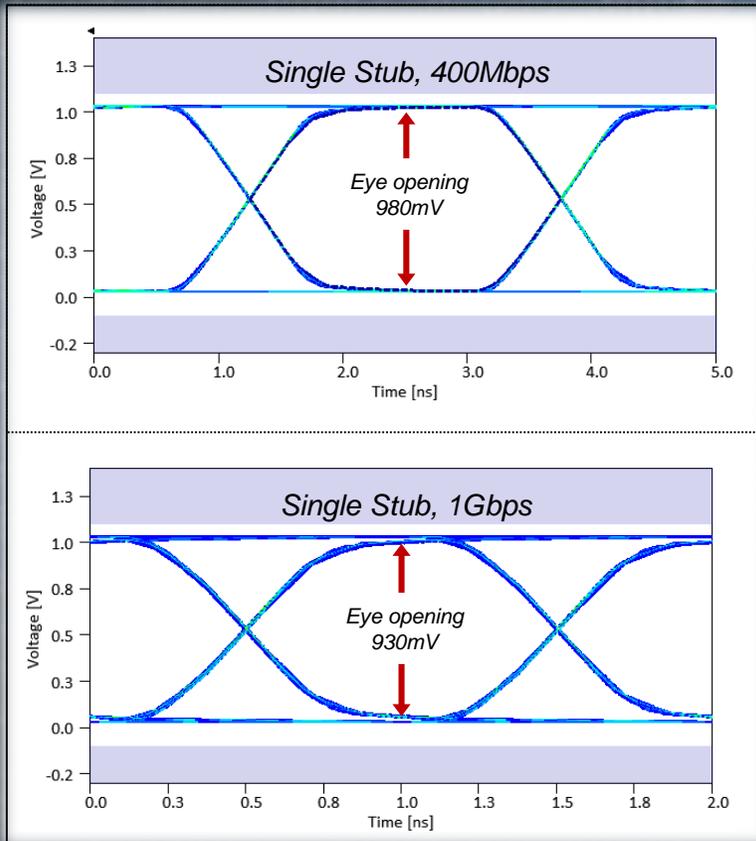


Fig. Eye-Diagram of Normal STF

Hybrid Type Space Transformer

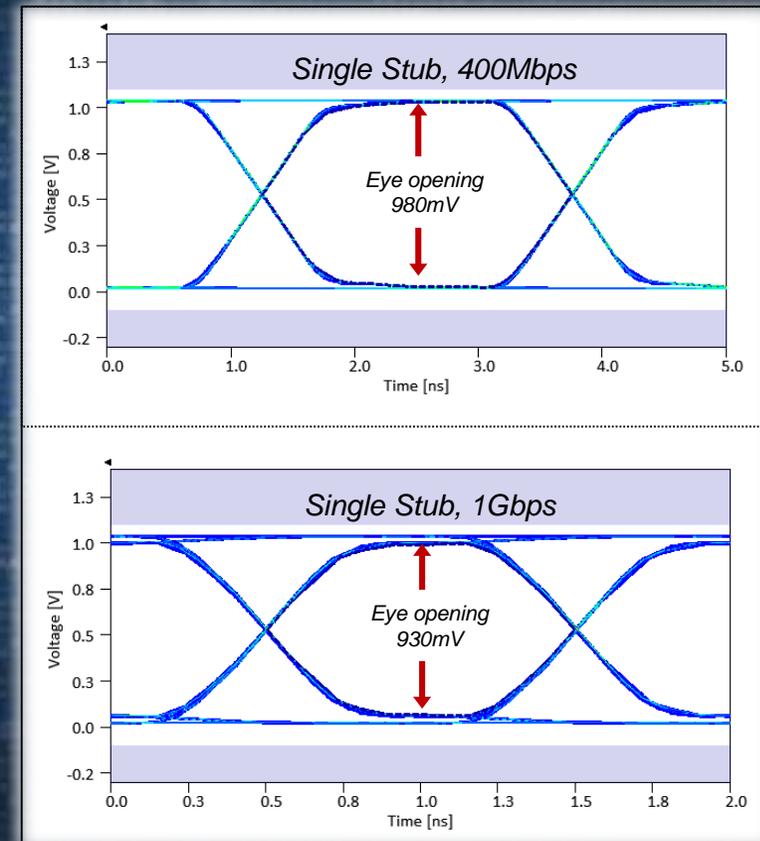


Fig. Eye-Diagram of Hybrid STF

Comparison

VS

Comparison

Signal Integrity of Space Transformer

- Measurement of Eye Diagram (Comparison of Two Types of Space Transformer)

Normal Type Space Transformer

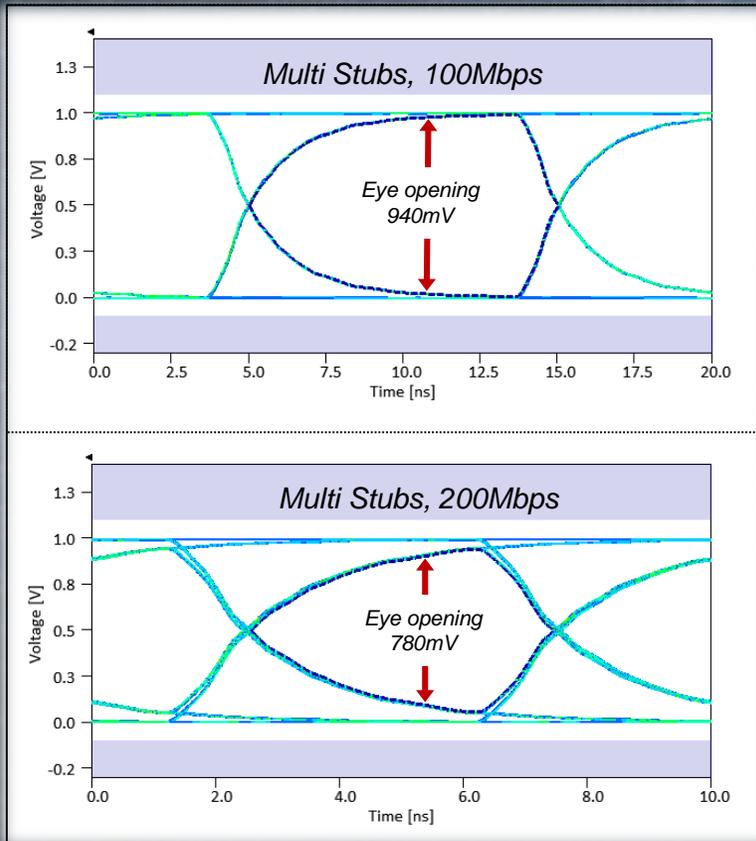


Fig. Eye-Diagram of Normal STF

← Comparison →

VS

← Comparison →

Hybrid Type Space Transformer

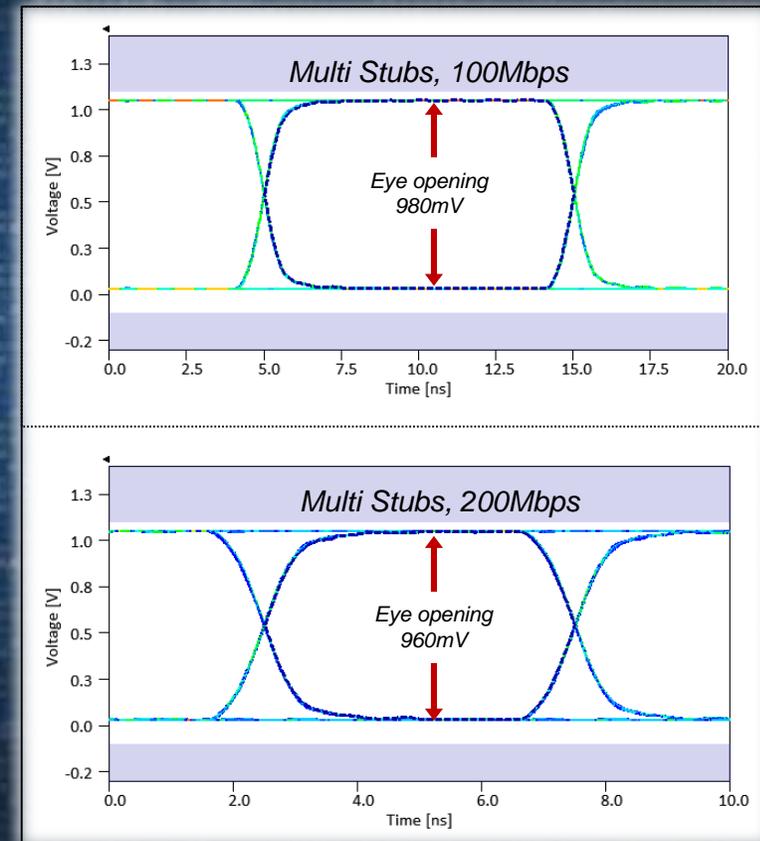


Fig. Eye-Diagram of Hybrid STF

Signal Integrity of Space Transformer

- Measurement of Eye Diagram (Comparison of Two Types of Space Transformer)

Normal Type Space Transformer

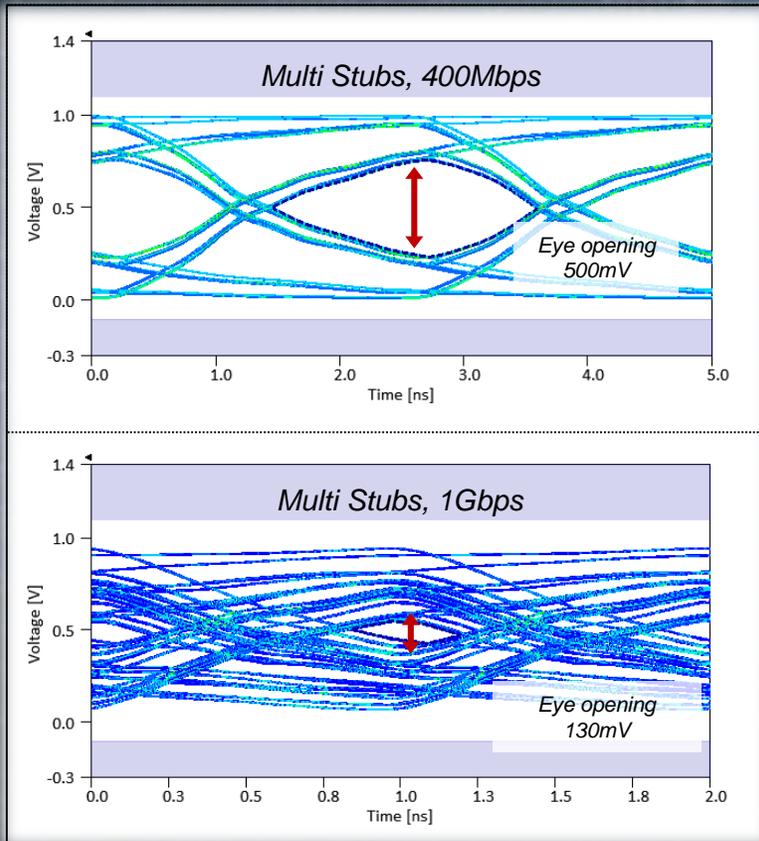


Fig. Eye-Diagram of Normal STF

Comparison

VS

Comparison

Hybrid Type Space Transformer

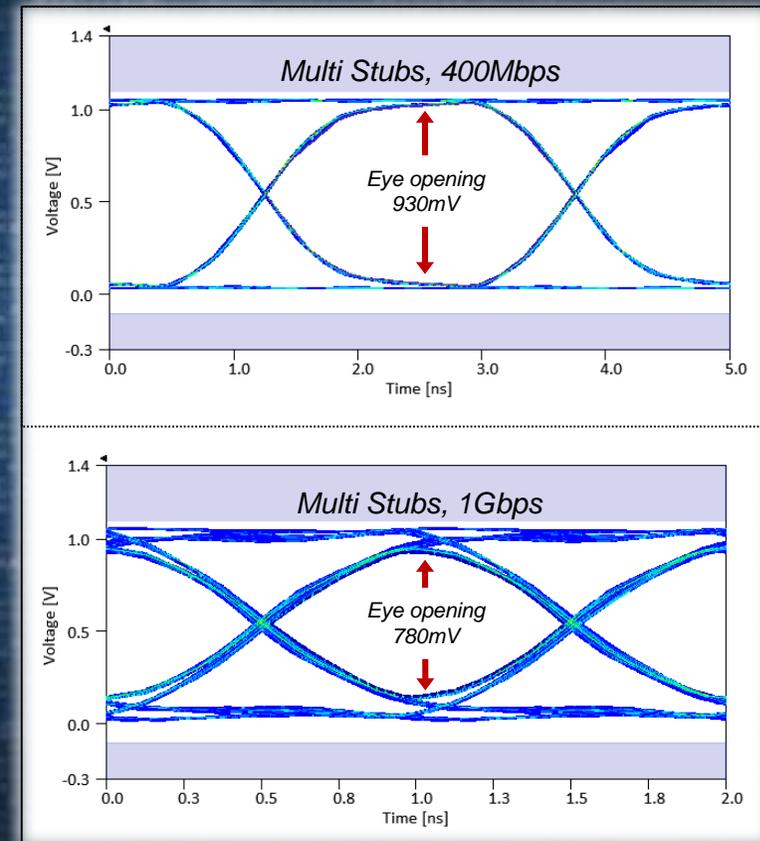


Fig. Eye-Diagram of Hybrid STF

SUMMARY

- ✓ *Designed the Space Transformer and Compared of Two Types of Space Transformer*
- ✓ *Performed the Basic Study of Signal and Power Design on Probe Card*
- ✓ *Measured Electrical Characteristics of Signal and Power at Space Transformer*
- ✓ *Analyzed Signal Integrity and Power Integrity for Space Transformer Performance*
- ✓ *Verified the Hybrid Type of Space Transformer on Probe Card*

Acknowledgements



- *SANG-KYU YOO*



- *YONG-HO CHO*

- *JONG-MYEON LEE*



- *JONG-GWAN YOOK*